

<b>Notice of References Cited</b>	Application/Control No. 10/607,000	Applicant(s)/Patent Under Reexamination OYASATO ET AL	
	Examiner Xiuqin Sun	Art Unit 2863	Page 1 of 1

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*	B	US-6,477,438	11-2002	Sakai et al.	700/97
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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